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David McComb | Materials Science and Engineering -

Center for Electron Microscopy and "High-Resolution Mapping of Electron-Beam-Excited Plasmon Modes environments in high-k materials for

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Michael Mills | Materials Science and Engineering -

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Jing Li - Georgia Institute of Technology -

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Xinghang Zhang | Texas A&M University | Papers - -

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His research areas include microstructures and defects of advanced materials resolution Transmission Electron Microscopy, Electron Microscopy to High

<http://www.uta.edu/profiles/Jiechao-Jiang>